

<p>Substitute for form 1449/PTO</p> <p><b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b></p> <p>Sheet 1 of 2</p>	<b>Complete if Known</b>	
	<b>Application Number</b>	10/815,604
	<b>Filing Date</b>	03/31/2004
	<b>First Inventor</b>	HO, Andrew
	<b>Art Unit</b>	2611
	<b>Examiner</b>	Perilla, Jason
	<b>Atty Docket #</b>	
	<b>Rambus #</b>	RA290.CIP1.US

US Patent Documents						
Examiner Initials*	Cite No.	Document No.	Date (MM- DD-YYYY)	Patentee	Class	Subclass
	0008660	2001- 0040922	11/15/2001	Buchali et al.	375	233
	0008098	2001- 0043658	11/22/2001	Voorman et al.	375	340
	0008661	2001- 0055335	12/27/2001	Agazzi et al.	375	232
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	0008665	2002- 0194539	12/19/2002	Ellis et al.	714	30
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	0002828	5539774	07/23/1996	Nobakht et al.	375	232
	0008658	5602602	02/11/1997	Hulyalkar,	348	607

<b>Examiner Signature:</b>	/Jason Perilla/	<b>Date Considered:</b>	09/08/2009
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. **Applicant is to place a check mark here if English language Translation is attached.</p>			

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /J.P./

# **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

Sheet 2 of 2

## **Complete if Known**

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## **US Patent Documents**

Examiner Initials*	Cite No.	Document No.	Date (MM- DD-YYYY)	Patentee	Class	Subclass
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	0008659	6016379	01/18/2000	Bulow, Henning	385	147
	0008110	6031866	02/29/2000	Oler et al.	375	219
	0008109	6307883	10/23/2001	Kanada et al.	375	231
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	0008664	6459727	10/01/2002	Cho et al.	375	222
	0008108	6459728	10/01/2002	Bar-David et al.	375	231
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	0008113	6691260	02/10/2004	Ueno	714	48
	0008107	6816558	11/09/2004	Piirainen et al.	375	316
	0008106	6947480	09/20/2005	Beale et al.	375	229
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	0008683	7130366	10/31/2006	Phanse et al.	375	350
	0008100	7203257	04/10/2007	Filmoff et al.	375	343

**Examiner  
Signature:**

/Jason Perilla/

**Date Considered:**

09/08/2009

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